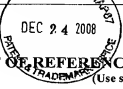


Sheet 1 of 1

 <p>LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)</p>	ATTY. DOCKET NO. 9301-159	APPLICATION NO. 10/520,031
	APPLICANT Marton <i>et al.</i>	
	FILING DATE June 27, 2003	ART UNIT 1637

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*Examiner Initials	Document Number	Date mm/dd/yy	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

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/Young J. Kim/

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